

MOSFETs Silicon P-/N-Channel MOS (U-MOSVI/U-MOSVI-H)

TPC8408

1. Applications

- · Mobile Equipments
- · Motor Drivers

2. Features

- (1) Small footprint due to a small and thin package
- (2) High speed switching
- (3) Low drain-source on-resistance

P-channel $\rm\,R_{DS(ON)}$ = 33 m Ω (typ.) (V $_{GS}$ = -10 V),

N-channel $R_{DS(ON)} = 24 \text{ m}\Omega$ (typ.) ($V_{GS} = 10 \text{ V}$)

(4) Low leakage current

P-channel $I_{DSS} = -10 \mu A \text{ (max) (V}_{DS} = -40 \text{ V)},$

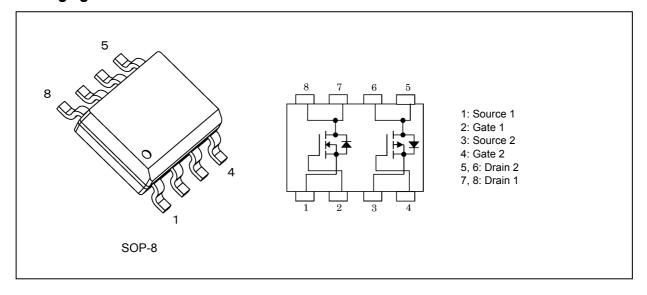
N-channel $I_{DSS} = 10 \mu A \text{ (max) (V}_{DS} = 40 \text{ V)}$

(5) Enhancement mode

P-channel V_{th} = -0.8 to -2.0 V (V_{DS} = -10 V, I_D = -0.1 mA),

N-channel V_{th} = 1.3 to 2.3 V (V_{DS} = 10 V, I_{D} = 0.1 mA)

3. Packaging and Internal Circuit





4. Absolute Maximum Ratings (Note) (Ta = 25°C unless otherwise specified)

Characteristics	P/N	Symbol	Rating	Unit		
Drain-source voltage	P-ch	V _{DSS}	-40	V		
			N-ch	1	40	
Gate-source voltage			P-ch	V _{GSS}	±20	
			N-ch	1	±20	1
Drain current (DC)		(Note 1)	P-ch	I _D	-5.3	Α
			N-ch	1	6.1	
Drain current (pulsed)	(Note 1)	P-ch	I _{DP}	-21.2	Α	
			N-ch	1	24.4	
Power dissipation (single operation)	(t = 10 s)	(Note 2), (Note 4)	P-ch	P _{D(1)}	1.5	w
			N-ch		1.5	1
Power dissipation (per device for dual	(t = 10 s)	(Note 2), (Note 5)	P-ch	P _{D(2)}	1.1	W
operation)			N-ch		1.1	
Power dissipation (single operation)	(t = 10 s)	(Note 3), (Note 4)	P-ch	P _{D(1)}	0.75	W
			N-ch		0.75	
Power dissipation (per device for dual	(t = 10 s)	(Note 3), (Note 5)	P-ch	P _{D(2)}	0.45	W
operation)			N-ch		0.45	
Single-pulse avalanche energy		(Note 6)	P-ch	E _{AS}	18	mJ
			N-ch	1	24	
Avalanche current			P-ch	I _{AR}	-5.3	Α
			N-ch	1	6.1	
Channel temperature			P-ch	T _{ch}	150	°C
			N-ch]	150	
Storage temperature			P-ch	T _{stg}	-55 to 150	°C
			N-ch]	-55 to 150	

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

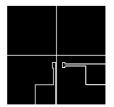
Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).



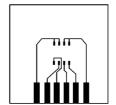
5. Thermal Characteristics

Characteristics	Symbol	Max	Unit		
Channel-to-ambient thermal resistance (single operation)	(t = 10 s)	(Note 2), (Note 4)	R _{th(ch-a)(1)}	83.3	°C/W
Channel-to-ambient thermal resistance (per device for dual operation)	(t = 10 s)	(Note 2), (Note 5)	R _{th(ch-a)(2)}	113	
Channel-to-ambient thermal resistance (single operation)	(t = 10 s)	(Note 3), (Note 4)	R _{th(ch-a)(1)}	166	
Channel-to-ambient thermal resistance (per device for dual operation)	(t = 10 s)	(Note 3), (Note 5)	R _{th(ch-a)(2)}	277	

- Note 1: Ensure that the channel temperature does not exceed 150°C.
- Note 2: Device mounted on a glass-epoxy board (a), Figure 5.1
- Note 3: Device mounted on a glass-epoxy board (b), Figure 5.2
- Note 4: Power dissipation and thermal resistance values per device with the other device being off (During single operation, power is supplied to only one of the two devices.)
- Note 5: Power dissipation and thermal resistance values per device for dual operation (During dual operation, power is evenly supplied to both devices.)
- Note 6: P channel: V_{DD} = -32 V, T_{ch} = 25°C (initial), L = 0.5 mH, R_G = 25 Ω , I_{AR} = -5.3 A N channel: V_{DD} = 32 V, T_{ch} = 25°C (initial), L = 0.5 mH, R_G = 25 Ω , I_{AR} = 6.1 A



 $\begin{aligned} &\text{FR-4}\\ &25.4\times25.4\times0.8\\ &\text{(Unit: mm)} \end{aligned}$



 $\begin{aligned} &\text{FR-4}\\ &25.4\times25.4\times0.8\\ &\text{(Unit: mm)} \end{aligned}$

Fig. 5.1 Device Mounted on a Glass-Epoxy Board (a)

Fig. 5.2 Device Mounted on a Glass-Epoxy Board (b)

Note: This transistor is sensitive to electrostatic discharge and should be handled with care.



6. Electrical Characteristics (T_a = 25°C unless otherwise specified)

6.1. Static Characteristics

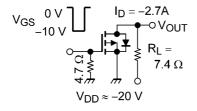
Characteristics	P/N	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current	P-ch	I _{GSS}	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$	_	_	±0.1	μА
	N-ch		$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$		_	±0.1	
Drain cut-off current	P-ch	I _{DSS}	V _{DS} = -40 V, V _{GS} = 0 V		_	-10	μΑ
	N-ch]	V _{DS} = 40 V, V _{GS} = 0 V	_	_	10	
Drain-source breakdown voltage	P-ch	V _{(BR)DSS}	I _D = -10 mA, V _{GS} = 0 V	-40	_	-	V
	N-ch		I _D = 10 mA, V _{GS} = 0 V	40	_	_	
Drain-source breakdown voltage (Note 7)	P-ch	V _{(BR)DSX}	I_D = -10 mA, V_{GS} = 10 V	-30	_		V
	N-ch		I_D = 10 mA, V_{GS} = -20 V	23	_		
Gate threshold voltage	P-ch	V _{th}	$V_{DS} = -10 \text{ V}, I_{D} = -0.1 \text{ mA}$	-0.8	_	-2.0	V
	N-ch		$V_{DS} = 10 \text{ V}, I_{D} = 0.1 \text{ mA}$	1.3	_	2.3	
Drain-source on-resistance	P-ch	R _{DS(ON)}	V_{GS} = -4.5 V, I_{D} = -2.7 A		41	53	mΩ
			V_{GS} = -10 V, I_D = -2.7 A	_	33	43	
	N-ch		V _{GS} = 4.5 V, I _D = 3.1 A	_	28	36	
			V _{GS} = 10 V, I _D = 3.1 A	_	24	32	

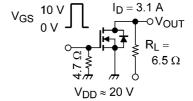
Note 7: If a reverse bias is applied between gate and source, this device enters $V_{(BR)DSX}$ mode. Note that the drain-source breakdown voltage is lowered in this mode.



6.2. Dynamic Characteristics

Characteristics	P/N	Symbol	Test Condition	Min	Тур.	Max	Unit
Input capacitance	P-ch	C _{iss}	V _{DS} = -10 V, V _{GS} = 0 V, f = 1 MHz	_	1105	_	pF
	N-ch		V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz	_	850	_	
Reverse transfer capacitance	P-ch	C _{rss}	V _{DS} = -10 V, V _{GS} = 0 V, f = 1 MHz	_	135	_	pF
	N-ch		V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz	_	40	_	
Output capacitance	P-ch	C _{oss}	V _{DS} = -10 V, V _{GS} = 0 V, f = 1 MHz	_	165	_	pF
	N-ch		V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz	_	145	_	
Switching time (rise time)	P-ch	t _r	See Figure 6.2.1.	_	8.1	_	ns
	N-ch		See Figure 6.2.2.	_	2.0	_	
Switching time (turn-on time)	P-ch	t _{on}	See Figure 6.2.1.	_	16	_	ns
	N-ch		See Figure 6.2.2.	_	7.0	_	
Switching time (fall time)	P-ch	t _f	See Figure 6.2.1.	_	33	_	ns
	N-ch		See Figure 6.2.2.	_	2.3	_	
Switching time (turn-off time)	P-ch	t _{off}	See Figure 6.2.1.	_	131	_	ns
	N-ch]	See Figure 6.2.2.	_	17	_	





Duty \leq 1%, $t_W=10~\mu s$

Duty \leq 1%, $t_W = 10~\mu s$

Fig. 6.2.1 Switching Time Test Circuit (P-ch) Fig. 6.2.2 Switching Time Test Circuit (N-ch)

6.3. Gate Charge Characteristics

Characteristics	P/N	Symbol	Test Condition	Min	Тур.	Max	Unit
Total gate charge (gate-source plus gate-drain)	P-ch	Qg	$V_{DD} \approx -32 \text{ V}, V_{GS} = -10 \text{ V}, I_D = -5.3 \text{ A}$	ı	24		nC
	N-ch		$V_{DD} \approx 32 \text{ V}, V_{GS} = 10 \text{ V},$ $I_D = 6.1 \text{ A}$		14		
Gate-source charge 1	P-ch	Q _{gs1}	$V_{DD} \approx -32 \text{ V}, V_{GS} = -10 \text{ V}, I_D = -5.3 \text{ A}$	_	3.0		nC
	N-ch		$V_{DD} \approx 32 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 6.1 \text{ A}$		2.6		
Gate-drain charge	P-ch	Q _{gd}	$V_{DD} \approx -32 \text{ V, } V_{GS} = -10 \text{ V,} $ $I_{D} = -5.3 \text{ A}$	_	5.3	-	nC
	N-ch		$V_{DD} \approx 32 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 6.1 \text{ A}$	_	2.4		



6.4. Source-Drain Characteristics

Characteristics		P/N	Symbol	Test Condition	Min	Тур.	Max	Unit
,	Note 8)	P-ch	I _{DRP}	_	_		-21.2	Α
(pulsed)		N-ch					24.4	
Diode forward voltage		P-ch	V_{DSF}	$I_{DR} = -5.3 \text{ A}, V_{GS} = 0 \text{ V}$			1.2	V
		N-ch		$I_{DR} = 6.1 \text{ A}, V_{GS} = 0 \text{ V}$	_	_	-1.2	

Note 8: Ensure that the channel temperature does not exceed 150°C.

7. Marking (Note)

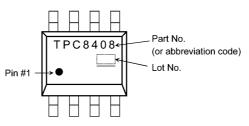


Fig. 7.1 Marking

Note: A line under a Lot No. identifies the indication of product Labels.

Not underlined: [[Pb]]/INCLUDES > MCV

Underlined: [[G]]/RoHS COMPATIBLE or [[G]]/RoHS [[Pb]]

Please contact your TOSHIBA sales representative for details as to environmental matters such as the RoHS compatibility of Product.

The RoHS is the Directive 2011/65/EU of the European Parliament and of the Council of 8 June 2011 on the restriction of the use of certain hazardous substances in electrical and electronic equipment.

8. Characteristics Curves (Note)

8.1. P-Channel MOSFET

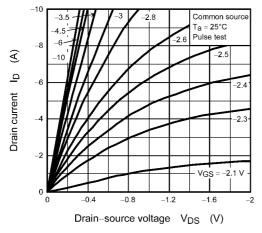


Fig. 8.1.1 $I_D - V_{DS}$

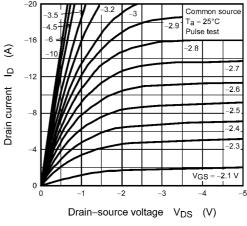


Fig. 8.1.2 $I_D - V_{DS}$

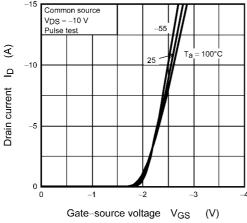


Fig. 8.1.3 I_D - V_{GS}

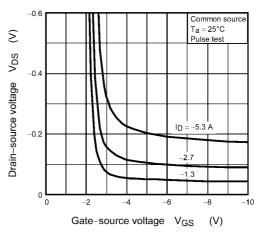


Fig. 8.1.4 V_{DS} - V_{GS}

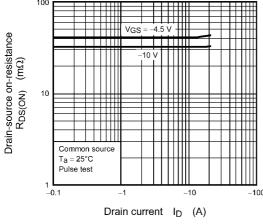


Fig. 8.1.5 R_{DS(ON)} - I_D

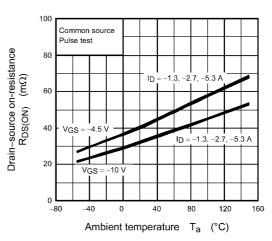


Fig. 8.1.6 R_{DS(ON)} - T_a

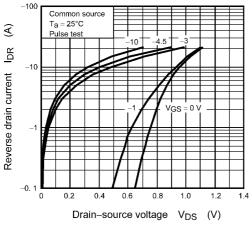


Fig. 8.1.7 IDR - VDS

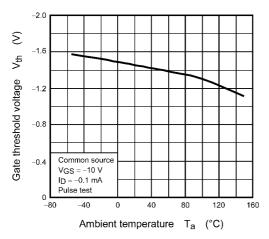


Fig. 8.1.9 V_{th} - T_a

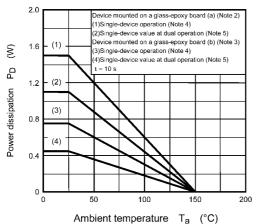


Fig. 8.1.11 P_D - T_a (Guaranteed Maximum)

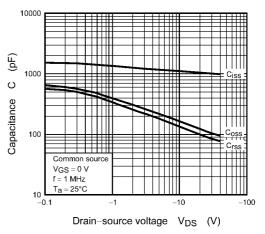


Fig. 8.1.8 Capacitance - V_{DS}

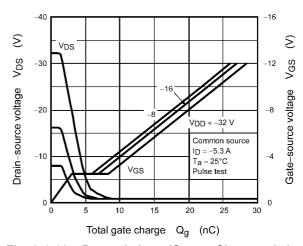


Fig. 8.1.10 Dynamic Input/Output Characteristics

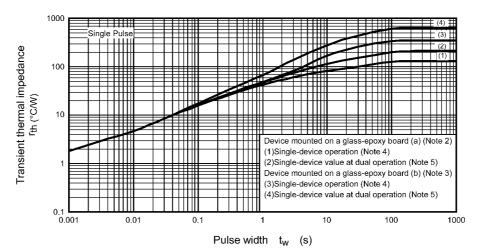


Fig. 8.1.12 r_{th} - t_w (Guaranteed Maximum)

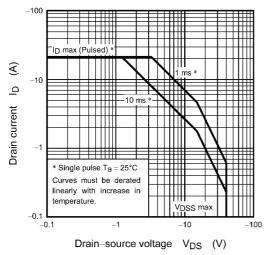


Fig. 8.1.13 Safe Operating Area (Guaranteed Maximum)



8.2. N-Channel MOSFET

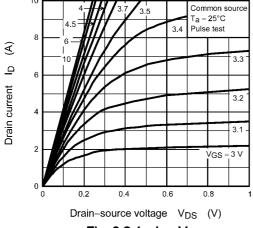


Fig. 8.2.1 $I_D - V_{DS}$

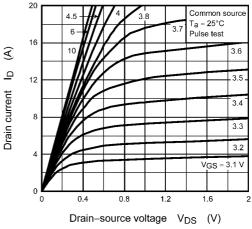


Fig. 8.2.2 I_D - V_{DS}

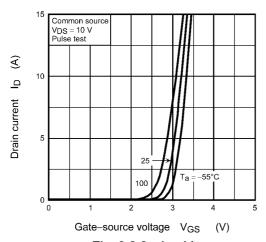


Fig. 8.2.3 I_D - V_{GS}

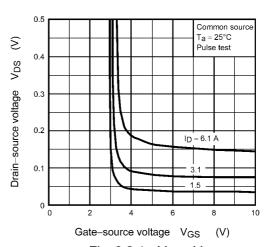


Fig. 8.2.4 V_{DS} - V_{GS}

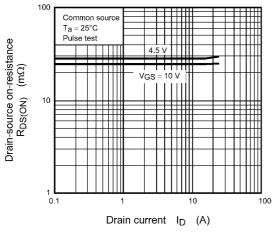


Fig. 8.2.5 R_{DS(ON)} - I_D

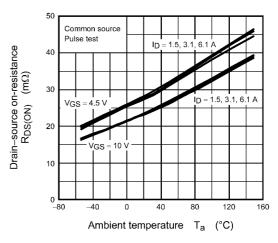


Fig. 8.2.6 R_{DS(ON)} - T_a

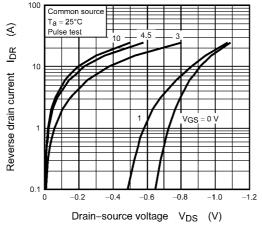


Fig. 8.2.7 IDR - VDS

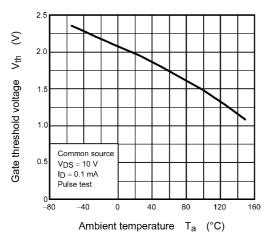


Fig. 8.2.9 Vth - Ta

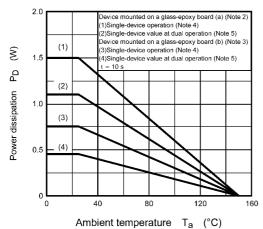


Fig. 8.2.11 P_D - T_a (Guaranteed Maximum)

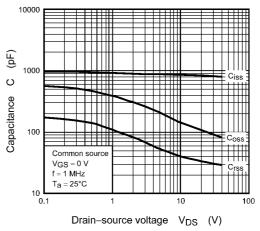


Fig. 8.2.8 Capacitance - V_{DS}

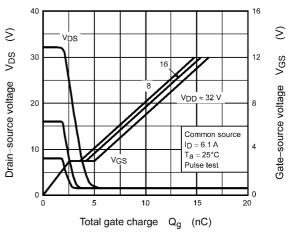


Fig. 8.2.10 Dynamic Input/Output Characteristics

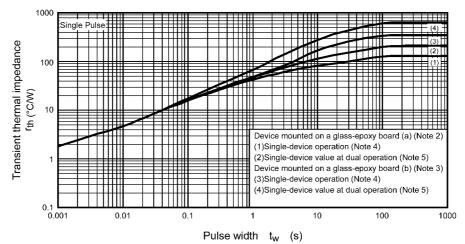


Fig. 8.2.12 r_{th} - t_w (Guaranteed Maximum)

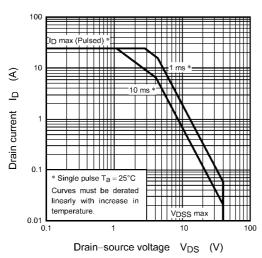


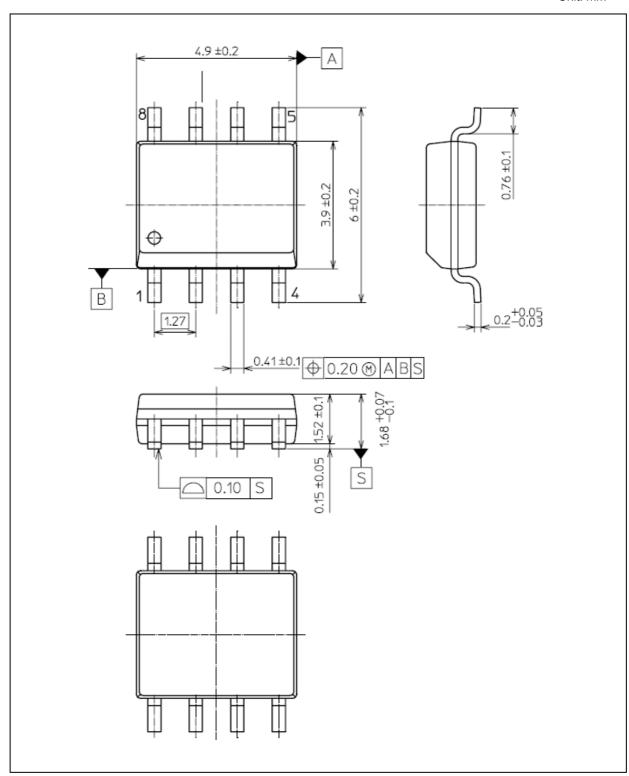
Fig. 8.2.13 Safe Operating Area (Guaranteed Maximum)

Note: The above characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.



Package Dimensions

Unit: mm



Weight: 0.085 g (typ.)

Package Name(s)
TOSHIBA: 2-5R1S
Nickname: SOP-8



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